

# PBSM5240PF

40 V, 2 A PNP low  $V_{CEsat}$  (BISS) transistor with N-channel Trench MOSFET

Rev. 2 — 20 April 2011

Product data sheet

## 1. Product profile

### 1.1 General description

Combination of PNP low  $V_{CEsat}$  Breakthrough In Small Signal (BISS) transistor and N-channel Trench MOSFET. The device is housed in a leadless medium power SOT1118 Surface-Mounted Device (SMD) plastic package.

### 1.2 Features and benefits

- Very low collector-emitter saturation voltage  $V_{CEsat}$
- High collector current capability  $I_C$  and  $I_{CM}$
- High collector current gain ( $h_{FE}$ ) at high  $I_C$
- High energy efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

### 1.3 Applications

- Loadswitch
- Power management
- Power switches (e.g. motors, fans)
- Battery-driven devices
- Charging circuits

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>PNP low <math>V_{CEsat}</math> (BISS) transistor</b>						
$V_{CEO}$	collector-emitter voltage	open base	-	-	-40	V
$I_C$	collector current		[1]	-	-1.8	A
$I_{CRM}$	repetitive peak collector current		[1][5]	-	-2	A
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	[1]	-	-3	A
$R_{CEsat}$	collector-emitter saturation resistance	$I_C = -500$ mA; $I_B = -50$ mA	[2]	-	240 340	m $\Omega$



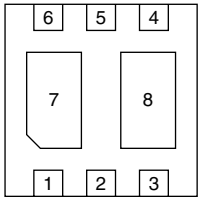
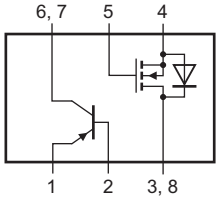
**Table 1. Quick reference data ...continued**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>N-channel Trench MOSFET</b>						
$V_{DS}$	drain-source voltage	$T_{amb} = 25\text{ °C}$	-	-	30	V
$V_{GS}$	gate-source voltage	$T_{amb} = 25\text{ °C}$	-	-	$\pm 8$	V
$I_D$	drain current	$T_{amb} = 25\text{ °C};$ $V_{GS} = 10\text{ V}$	[3]	-	0.66	A
$R_{DSon}$	drain-source on-state resistance	$T_j = 25\text{ °C}; V_{GS} = 4.5\text{ V};$ $I_D = 0.2\text{ A}$	[4]	-	370 580	m $\Omega$

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [2] Pulse test:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0.02$ .
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.
- [4] Pulse test:  $t_p \leq 300\ \mu\text{s}; \delta \leq 0.01$ .
- [5] Pulse test:  $t_p \leq 20\text{ ms}; \delta \leq 0.10$ .

## 2. Pinning information

**Table 2. Pinning**

Pin	Description	Simplified outline	Graphic symbol
1	emitter	 <p>Transparent top view</p>	 <p>017aaa079</p>
2	base		
3	drain		
4	source		
5	gate		
6	collector		
7	collector		
8	drain		

## 3. Ordering information

**Table 3. Ordering information**

Type number	Package		
	Name	Description	Version
PBSM5240PF	HUSON6	plastic thermal enhanced ultra thin small outline package; no leads; 6 terminals; body 2 × 2 × 0.65 mm	SOT1118

## 4. Marking

**Table 4. Marking codes**

Type number	Marking code
PBSM5240PF	1G

## 5. Limiting values

**Table 5. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

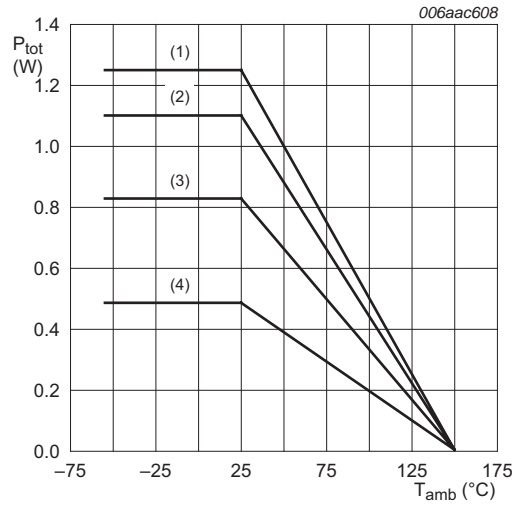
Symbol	Parameter	Conditions	Min	Max	Unit
<b>PNP low <math>V_{CEsat}</math> (BISS) transistor</b>					
$V_{CBO}$	collector-base voltage	open emitter	-	-40	V
$V_{CEO}$	collector-emitter voltage	open base	-	-40	V
$V_{EBO}$	emitter-base voltage	open collector	-	-5	V
$I_C$	collector current		[1]	-1.8	A
$I_{CRM}$	repetitive peak collector current		[1][4]	-2	A
$I_{CM}$	peak collector current	single pulse; $t_p \leq 1$ ms	[1]	-3	A
$I_B$	base current		[1]	-300	mA
$I_{BM}$	peak base current	single pulse; $t_p \leq 1$ ms	[1]	-1	A
$P_{tot}$	total power dissipation	$T_{amb} \leq 25$ °C	[1]	1.1	W
			[2]	1.25	W
<b>N-channel Trench MOSFET</b>					
$V_{DS}$	drain-source voltage	$T_{amb} = 25$ °C	-	30	V
$V_{DG}$	drain-gate voltage	$T_{amb} = 25$ °C; $R_{GS} = 20$ k $\Omega$	-	30	V
$V_{GS}$	gate-source voltage	$T_{amb} = 25$ °C	-	$\pm 8$	V
$I_D$	drain current	$V_{GS} = 10$ V	[3]		
		$T_{amb} = 25$ °C	-	660	mA
		$T_{amb} = 100$ °C	-	420	mA
$I_{DM}$	peak drain current	$T_{amb} = 25$ °C; single pulse; $t_p \leq 10$ $\mu$ s	-	3.56	A
$P_{tot}$	total power dissipation	$T_{amb} = 25$ °C	[3]	760	mW
<b>Source-drain diode</b>					
$I_S$	source current	$T_{amb} = 25$ °C	-	660	mA
<b>Per device</b>					
$T_j$	junction temperature		-	150	°C
$T_{amb}$	ambient temperature		-55	+150	°C
$T_{stg}$	storage temperature		-65	+150	°C

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.

[2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.

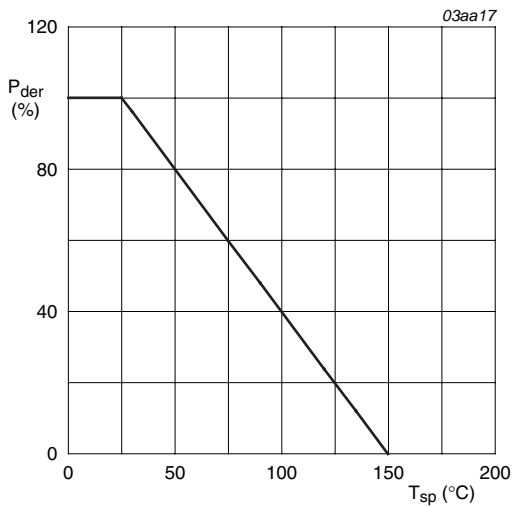
[3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.

[4] Pulse test:  $t_p \leq 20$  ms;  $\delta \leq 0.10$ .



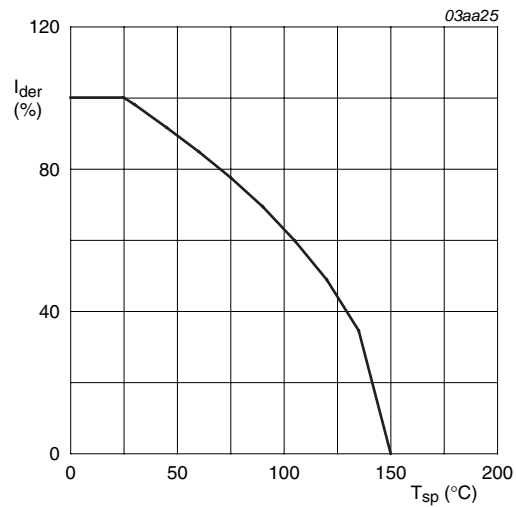
- (1) FR4 PCB, 4-layer copper, mounting pad for collector 1 cm<sup>2</sup>
- (2) FR4 PCB, single-sided copper, mounting pad for collector 6 cm<sup>2</sup>
- (3) FR4 PCB, single-sided copper, mounting pad for collector 1 cm<sup>2</sup>
- (4) FR4 PCB, single-sided copper, standard footprint

Fig 1. BISS transistor: Power derating curves



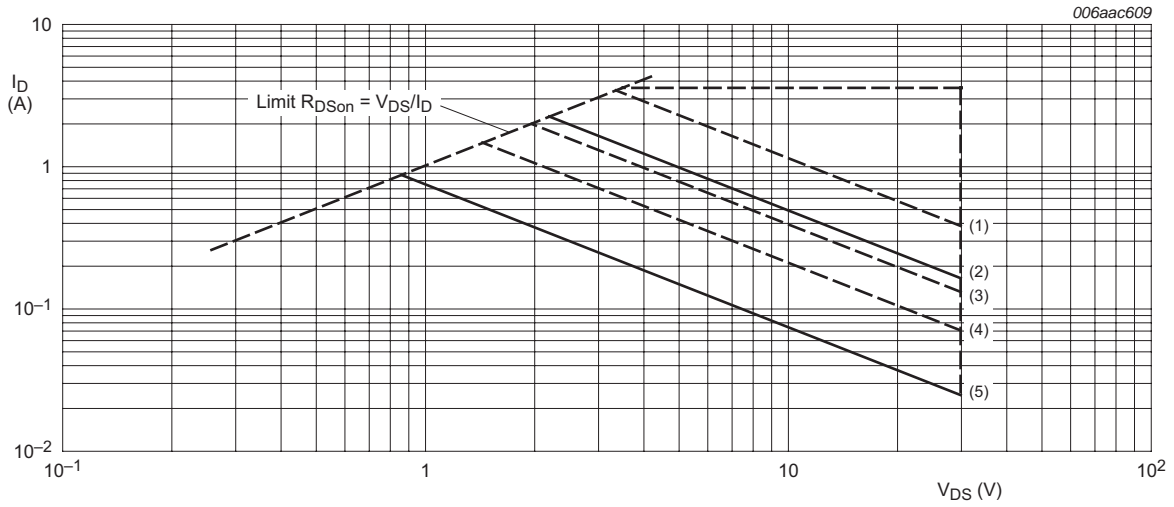
$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

Fig 2. MOSFET: Normalized total power dissipation as a function of solder point temperature



$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100\%$$

Fig 3. MOSFET: Normalized continuous drain current as a function of solder point temperature



- $I_{DM}$  = single pulse
- (1)  $t_p = 1$  ms
  - (2) DC;  $T_{sp} = 25$  °C
  - (3)  $t_p = 10$  ms
  - (4)  $t_p = 100$  ms
  - (5) DC;  $T_{amb} = 25$  °C; drain mounting pad  $1$  cm<sup>2</sup>

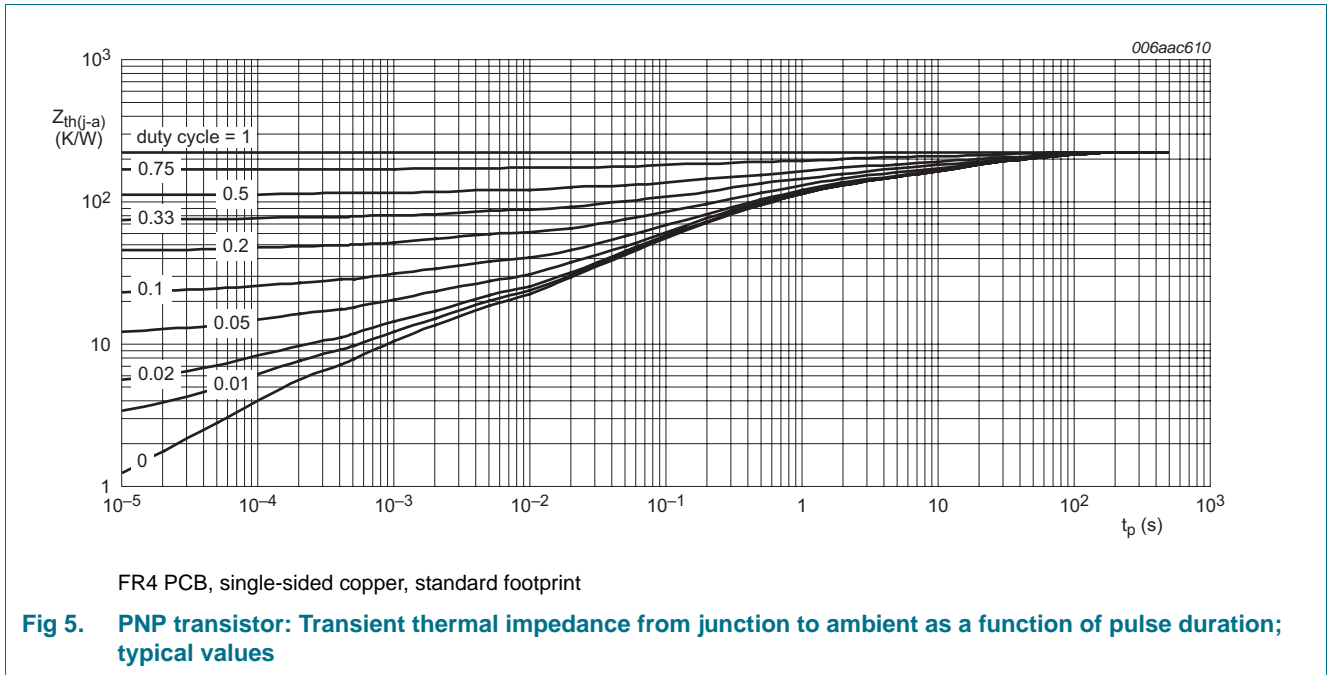
**Fig 4. MOSFET: Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage**

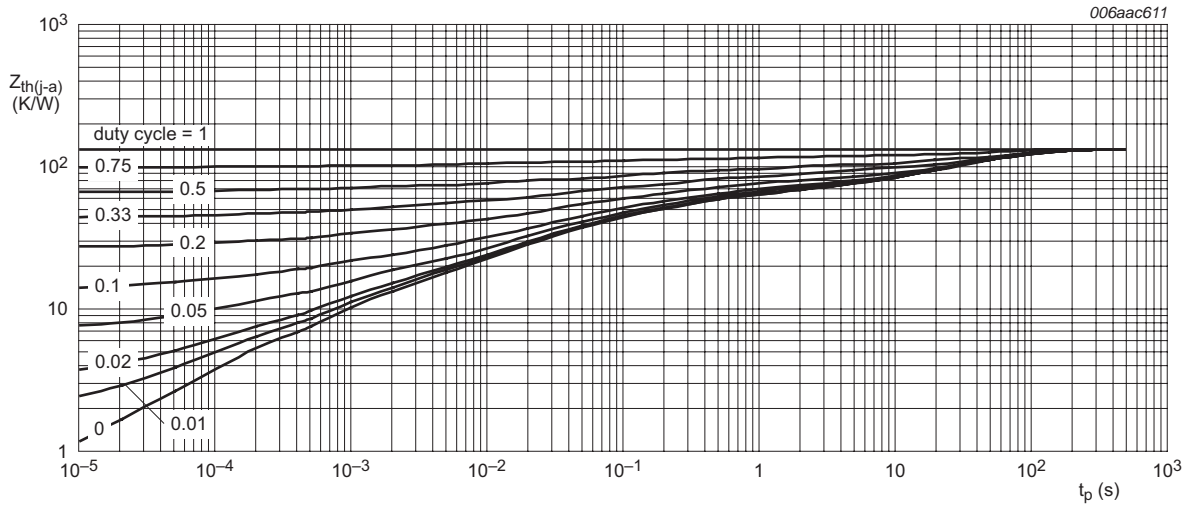
**6. Thermal characteristics**

**Table 6. Thermal characteristics**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
<b>PNP low <math>V_{CEsat}</math> (BISS) transistor</b>							
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	-	115	K/W
			[2]	-	-	100	K/W
<b>N-channel Trench MOSFET</b>							
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[3]	-	-	165	K/W

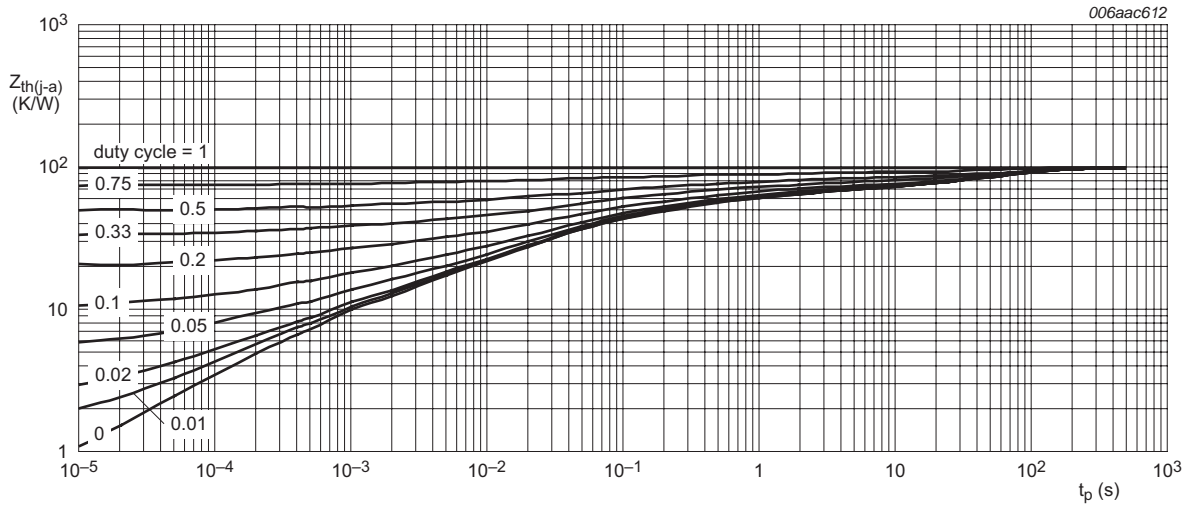
- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [2] Device mounted on an FR4 PCB, 4-layer copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.





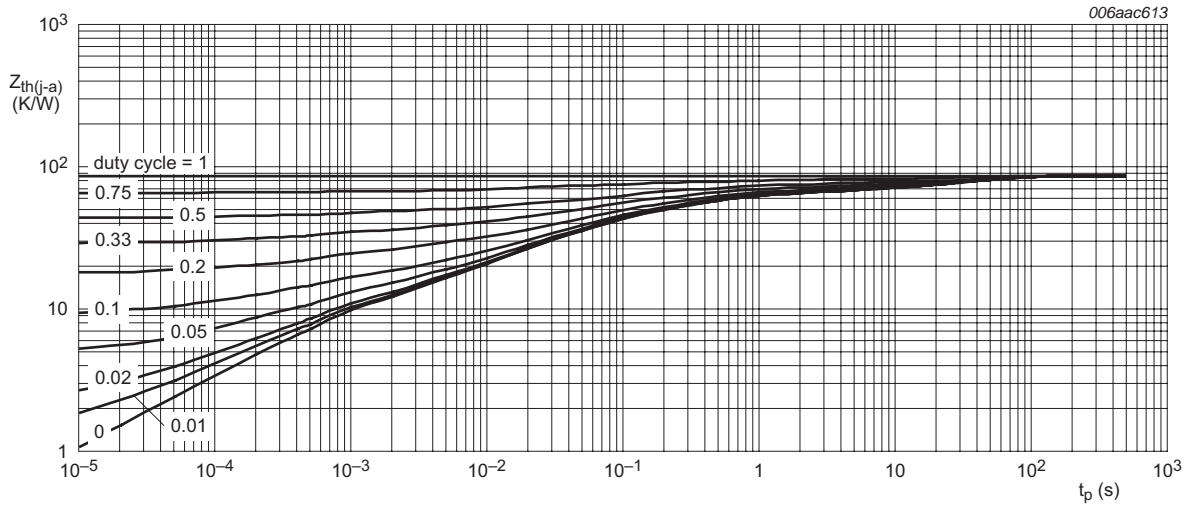
FR4 PCB, single-sided copper, mounting pad for collector 1 cm<sup>2</sup>

**Fig 6. PNP transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



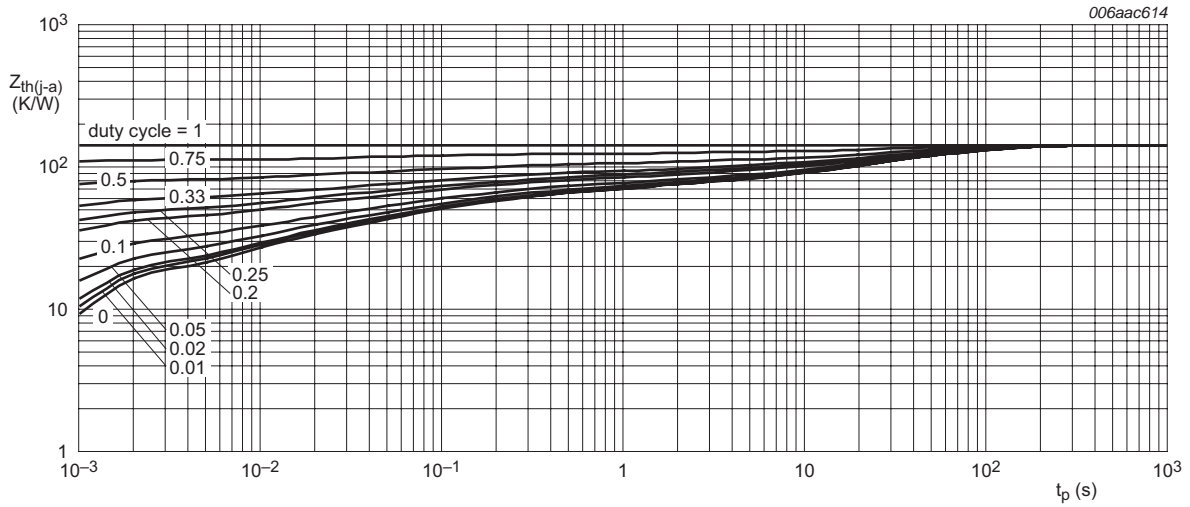
FR4 PCB, single-sided copper, mounting pad for collector 6 cm<sup>2</sup>

**Fig 7. PNP transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



FR4 PCB, 4-layer copper, mounting pad for collector 1 cm<sup>2</sup>

**Fig 8. PNP transistor: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



FR4 PCB, single-sided copper, mounting pad for drain 1 cm<sup>2</sup>

**Fig 9. MOSFET: Transient thermal impedance from junction to ambient as a function of pulse duration; typical values**



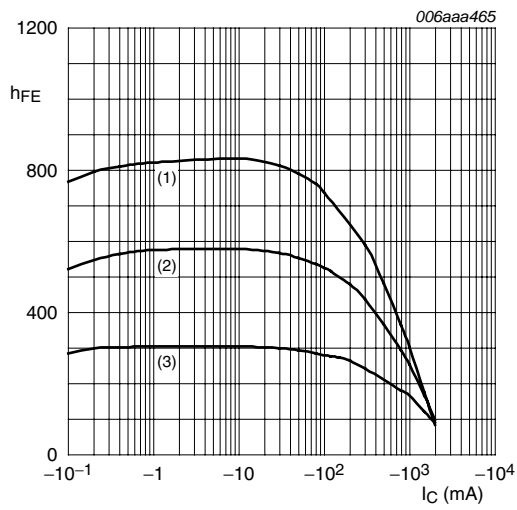
## 7. Characteristics

**Table 7. Characteristics for PNP low  $V_{CEsat}$  transistor**

$T_{amb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified.

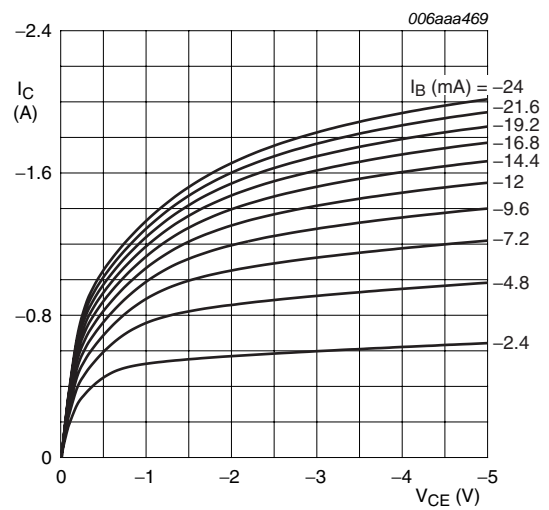
Symbol	Parameter	Conditions	Min	Typ	Max	Unit	
$I_{CBO}$	collector-base cut-off current	$V_{CB} = -40\text{ V}; I_E = 0\text{ A}$	-	-	-100	nA	
		$V_{CB} = -40\text{ V}; I_E = 0\text{ A}; T_j = 150\text{ }^{\circ}\text{C}$	-	-	-50	$\mu\text{A}$	
$I_{CEO}$	collector-emitter cut-off current	$V_{CE} = -30\text{ V}; I_B = 0\text{ A}$	-	-	-100	nA	
$I_{EBO}$	emitter-base cut-off current	$V_{EB} = -5\text{ V}; I_C = 0\text{ A}$	-	-	-100	nA	
$h_{FE}$	DC current gain	$V_{CE} = -5\text{ V}$	[1]				
		$I_C = -1\text{ mA}$	300	-	-		
		$I_C = -100\text{ mA}$	300	-	800		
		$I_C = -500\text{ mA}$	200	-	-		
		$I_C = -1\text{ A}$	140	-	-		
$V_{CEsat}$	collector-emitter saturation voltage	$I_C = -100\text{ mA}; I_B = -1\text{ mA}$	[1]	-	-85	-140	mV
		$I_C = -500\text{ mA}; I_B = -50\text{ mA}$	[1]	-	-120	-170	mV
		$I_C = -1\text{ A}; I_B = -100\text{ mA}$	[1]	-	-200	-310	mV
$R_{CEsat}$	collector-emitter saturation resistance	$I_C = -500\text{ mA}; I_B = -50\text{ mA}$	[1]	-	240	340	$\text{m}\Omega$
$V_{BEsat}$	base-emitter saturation voltage	$I_C = -1\text{ A}; I_B = -100\text{ mA}$	[1]	-	-	-1.1	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = -5\text{ V}; I_C = -1\text{ A}$	[1]	-	-	-1	V
$f_T$	transition frequency	$V_{CE} = -10\text{ V}; I_C = -50\text{ mA}; f = 100\text{ MHz}$	150	-	-		MHz
$C_c$	collector capacitance	$V_{CB} = -10\text{ V}; I_E = i_e = 0\text{ A}; f = 1\text{ MHz}$	-	-	12		pF

[1] Pulse test:  $t_p \leq 300\text{ }\mu\text{s}$ ;  $\delta \leq 0.02$ .



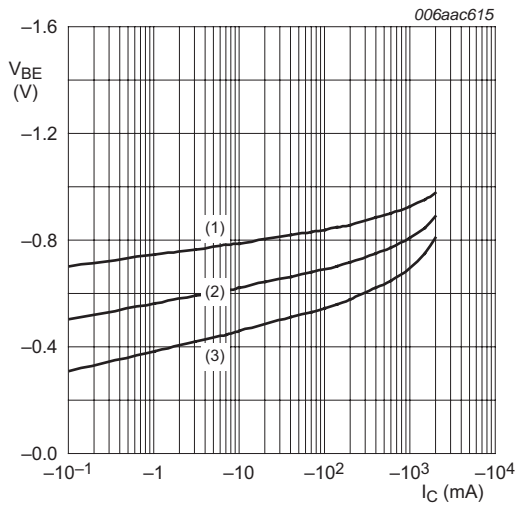
$V_{CEsat} = -5\text{ V}$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 10. PNP transistor: DC current gain as a function of collector current; typical values**



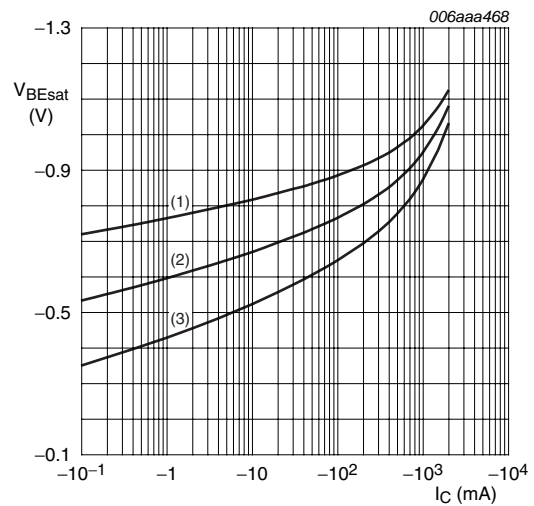
$T_{amb} = 25\text{ °C}$

**Fig 11. PNP transistor: Collector current as a function of collector-emitter voltage; typical values**



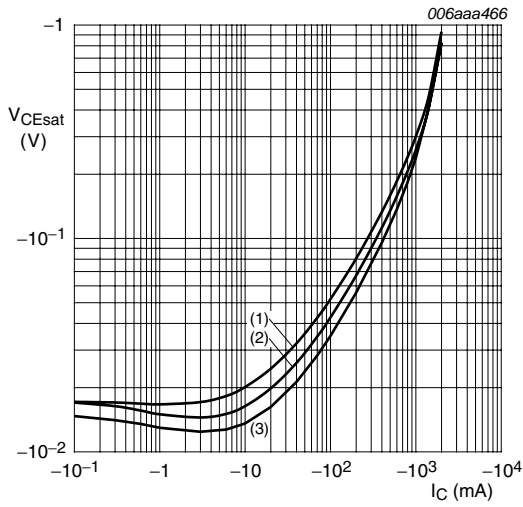
$V_{CEsat} = -5\text{ V}$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

**Fig 12. PNP transistor: Base-emitter voltage as a function of collector current; typical values**



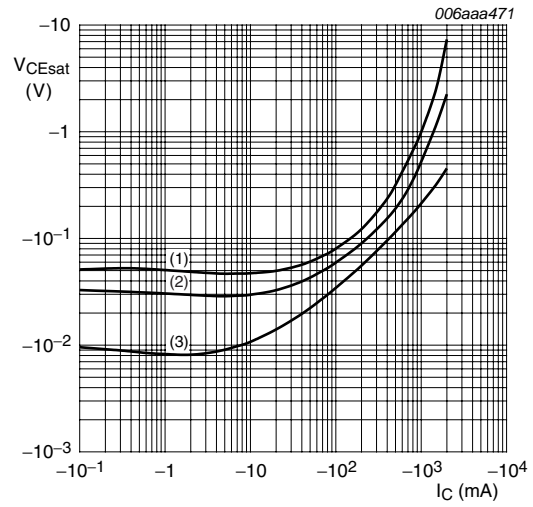
$I_C/I_B = 20$   
 (1)  $T_{amb} = -55\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = 100\text{ °C}$

**Fig 13. PNP transistor: Base-emitter saturation voltage as a function of collector current; typical values**



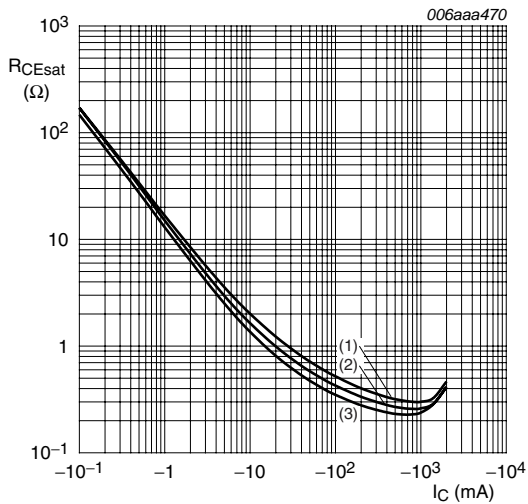
$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 14. PNP transistor: Collector-emitter saturation voltage as a function of collector current; typical values**



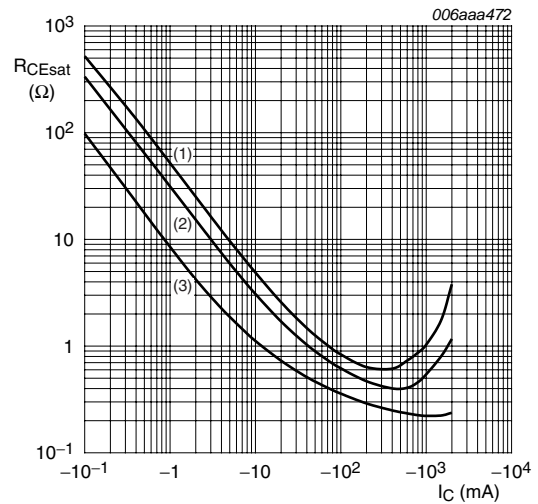
$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

**Fig 15. PNP transistor: Collector-emitter saturation voltage as a function of collector current; typical values**



$I_C/I_B = 20$   
 (1)  $T_{amb} = 100\text{ °C}$   
 (2)  $T_{amb} = 25\text{ °C}$   
 (3)  $T_{amb} = -55\text{ °C}$

**Fig 16. PNP transistor: Collector-emitter saturation resistance as a function of collector current; typical values**



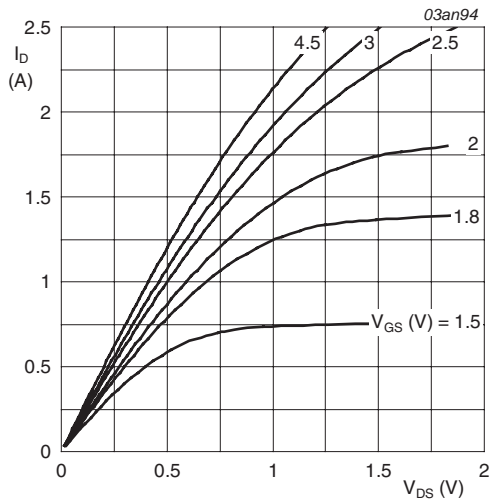
$T_{amb} = 25\text{ °C}$   
 (1)  $I_C/I_B = 100$   
 (2)  $I_C/I_B = 50$   
 (3)  $I_C/I_B = 10$

**Fig 17. PNP transistor: Collector-emitter saturation resistance as a function of collector current; typical values**

**Table 8. Characteristics for N-channel Trench MOSFET***T<sub>j</sub> = 25 °C unless otherwise specified.*

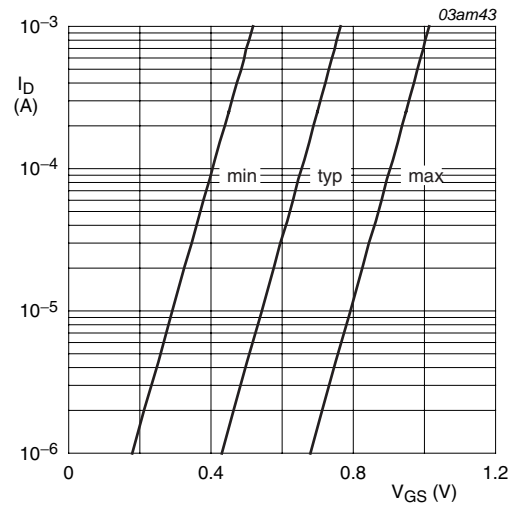
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>Static characteristics</b>						
V <sub>(BR)DSS</sub>	drain-source breakdown voltage	I <sub>D</sub> = 10 μA; V <sub>GS</sub> = 0 V				
		T <sub>j</sub> = 25 °C	30	-	-	V
		T <sub>j</sub> = -55 °C	27	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 250 μA; V <sub>DS</sub> = V <sub>GS</sub>				
		T <sub>j</sub> = 25 °C	0.45	0.7	0.95	V
		T <sub>j</sub> = 150 °C	0.25	-	-	V
		T <sub>j</sub> = -55 °C	-	-	1.15	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 30 V; V <sub>GS</sub> = 0 V				
		T <sub>j</sub> = 25 °C	-	-	1	μA
		T <sub>j</sub> = 150 °C	-	-	100	μA
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = ±8 V; V <sub>DS</sub> = 0 V	-	10	±100	nA
R <sub>DS(on)</sub>	drain-source on-state resistance	V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 0.2 A <a href="#">[1]</a>				
		T <sub>j</sub> = 25 °C	-	370	580	mΩ
		T <sub>j</sub> = 150 °C	-	663	985	mΩ
		V <sub>GS</sub> = 2.5 V; I <sub>D</sub> = 0.1 A	-	440	690	mΩ
		V <sub>GS</sub> = 1.8 V; I <sub>D</sub> = 75 mA	-	540	920	mΩ
<b>Dynamic characteristics</b>						
Q <sub>G(tot)</sub>	total gate charge	I <sub>D</sub> = 1 A; V <sub>DS</sub> = 15 V;	-	0.89	-	nC
Q <sub>GS</sub>	gate-source charge	V <sub>GS</sub> = 4.5 V	-	0.1	-	nC
Q <sub>GD</sub>	gate-drain charge		-	0.2	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V;	-	43	-	pF
C <sub>oss</sub>	output capacitance	f = 1 MHz	-	7.7	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	4.8	-	pF
t <sub>d(on)</sub>	turn-on delay time	V <sub>DS</sub> = 15 V; R <sub>L</sub> = 15 Ω;	-	4.0	-	ns
t <sub>r</sub>	rise time	V <sub>GS</sub> = 10 V; R <sub>G</sub> = 6 Ω	-	7.5	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	18	-	ns
t <sub>f</sub>	fall time		-	4.5	-	ns
<b>Source-drain diode</b>						
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 0.3 A; V <sub>GS</sub> = 0 V	-	0.76	1.2	V

[1] Pulse test: t<sub>p</sub> ≤ 300 μs; δ ≤ 0.01.



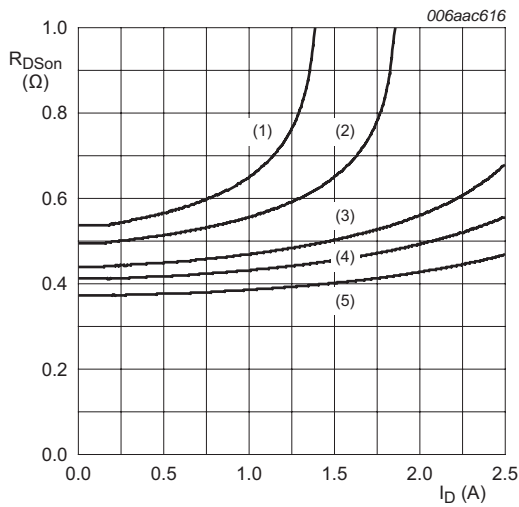
$T_j = 25\text{ }^\circ\text{C}$

**Fig 18. MOSFET: Output characteristics: drain current as a function of drain-source voltage; typical values**



$T_j = 25\text{ }^\circ\text{C}; V_{DS} = 5\text{ V}$

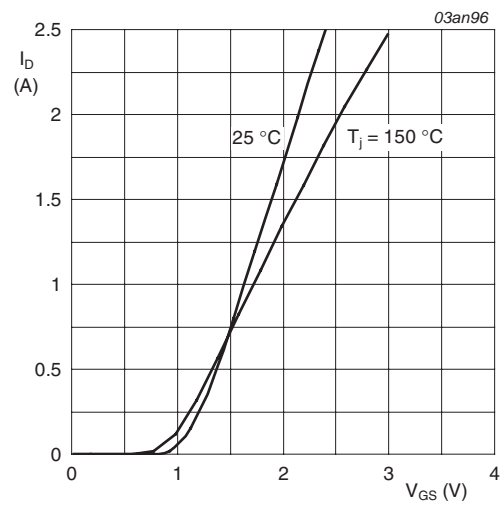
**Fig 19. MOSFET: Sub-threshold drain current as a function of gate-source voltage**



$T_j = 25\text{ }^\circ\text{C}$

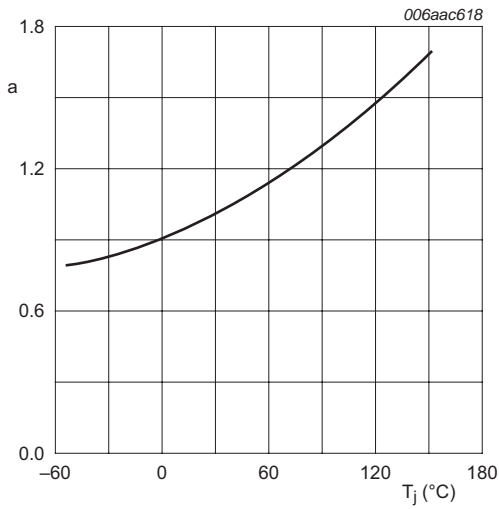
- (1)  $V_{GS} = 1.8\text{ V}$
- (2)  $V_{GS} = 2.0\text{ V}$
- (3)  $V_{GS} = 2.5\text{ V}$
- (4)  $V_{GS} = 3.0\text{ V}$
- (5)  $V_{GS} = 4.5\text{ V}$

**Fig 20. MOSFET: Drain-source on-state resistance as a function of drain current; typical values**



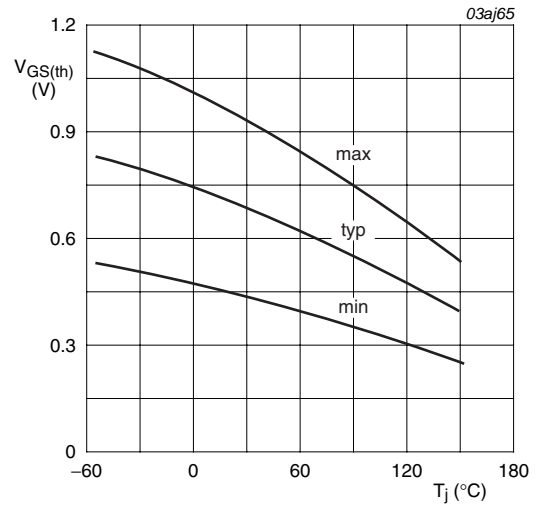
$V_{DS} > I_D \times R_{DSon}$

**Fig 21. MOSFET: Transfer characteristics: drain current as a function of gate-source voltage; typical values**



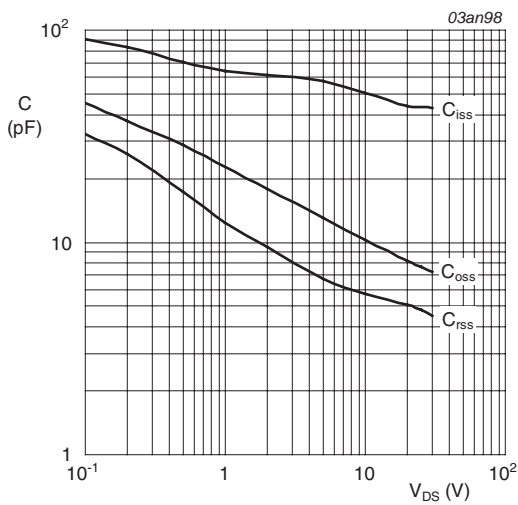
$$a = \frac{R_{DSon}}{R_{DSon(25^\circ C)}}$$

Fig 22. MOSFET: Normalized drain-source on-state resistance as a function of junction temperature; typical values



$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 23. MOSFET: Gate-source threshold voltage as a function of junction temperature



$f = 1 \text{ MHz}; V_{GS} = 0 \text{ V}$

Fig 24. MOSFET: Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

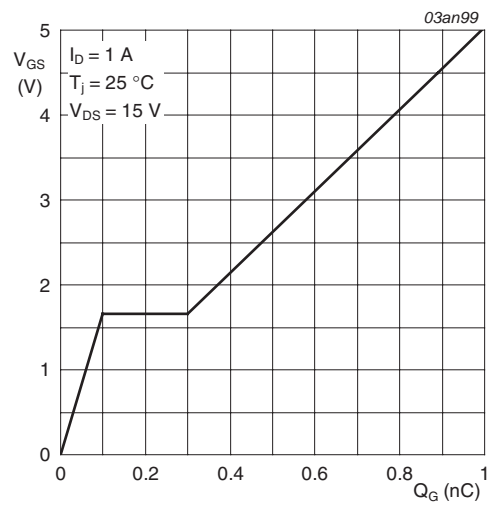
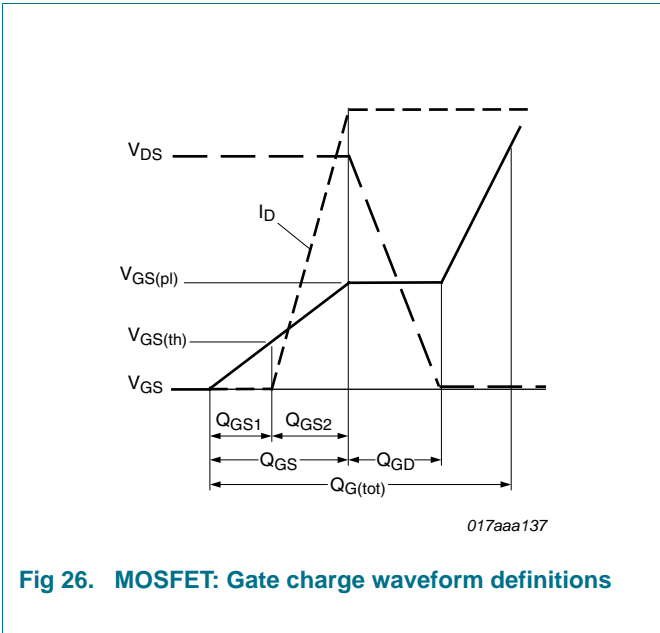
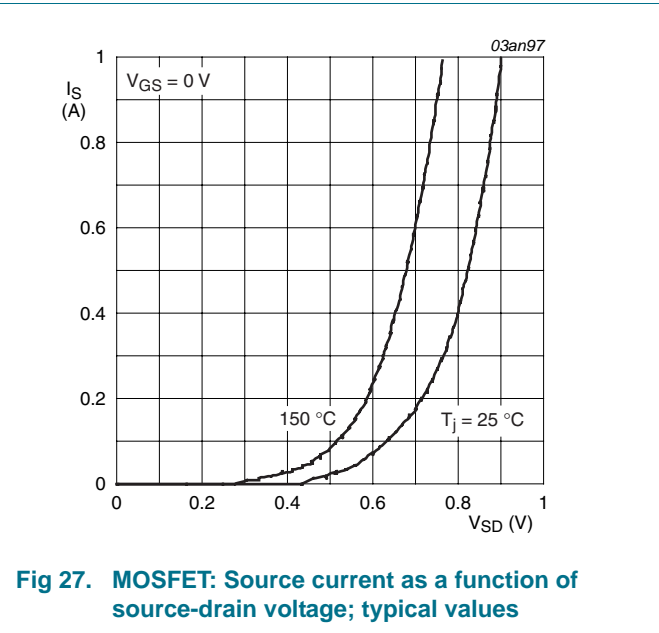


Fig 25. MOSFET: Gate-source voltage as a function of gate charge; typical values

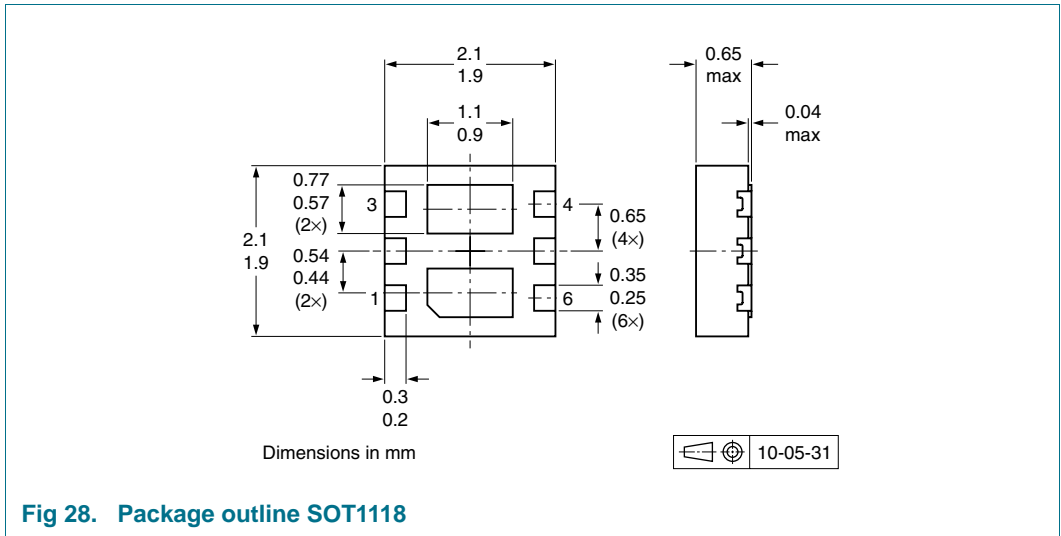


**Fig 26. MOSFET: Gate charge waveform definitions**



**Fig 27. MOSFET: Source current as a function of source-drain voltage; typical values**

## 8. Package outline



**Fig 28. Package outline SOT1118**

## 9. Packing information

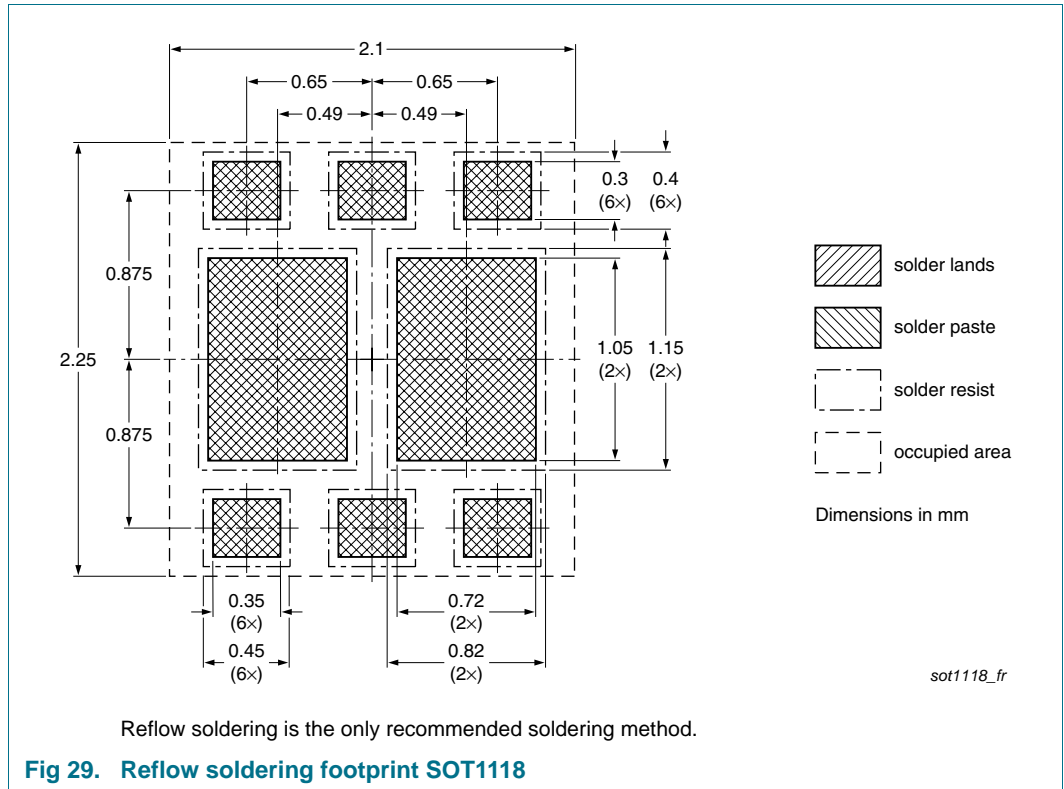
**Table 9. Packing methods**

The indicated -xxx are the last three digits of the 12NC ordering code.<sup>[1]</sup>

Type number	Package	Description	Packing quantity
PBSM5240PF	SOT1118	4 mm pitch, 8 mm tape and reel	3000
			-115

[1] For further information and the availability of packing methods, see [Section 13](#).

**10. Soldering**





## 11. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSM5240PF v.2	20110420	Product data sheet	-	PBSM5240PF v.1
Modifications:		<ul style="list-style-type: none"><li>• <a href="#">Section 1.1 “General description”</a>: updated.</li><li>• <a href="#">Section 2 “Pinning information”</a>: updated.</li><li>• <a href="#">Table 1, 5, 6, 7</a> and <a href="#">8</a>: updated according to the last measurements.</li><li>• <a href="#">Figure 1</a> to <a href="#">27</a>: added.</li><li>• <a href="#">Section 12 “Legal information”</a>: updated.</li></ul>		
PBSM5240PF v.1	20100825	Preliminary data sheet	-	-

## 12. Legal information

### 12.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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